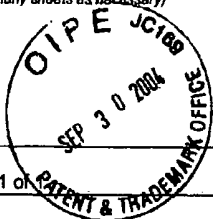


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PTO/SB/09A(10-01)
Approved for use through 10/31/2002. OMB 051-0031
US Patent & Trademark Office: U.S. DEPARTMENT OF COMMERCE

Complete if Known

Application Number	09/816,602
Filing Date	March 23, 2001
First Named Inventor	Jenson, Mark L.
Group Art Unit	1746
Examiner Name	Crepeau, Jonathan

Attorney Docket No: 1327.010US1

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J. G.

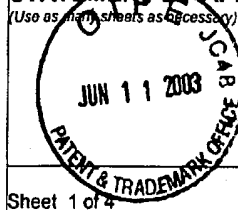
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PTO/SB/06A(10-01)
 Approved for use through 10/31/2002. OMB 051-0031
 US Patent & Trademark Office U.S. DEPARTMENT OF COMMERCE

Complete if Known	
Application Number	09/816602
Filing Date	March 23, 2001
First Named Inventor	Jensen, Mark
Group Art Unit	1745
Examiner Name	Winter, Gentle
Attorney Docket No: 1327.010US1	

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DATE CONSIDERED 7/7/03

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 * EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. 1 Applicant's unique citation designation number (optional) 2 Applicant is to place a check mark here if English language Translation is attached



Electronic Information Disclosure Statement

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GROUP 170

DEVICE ENCLOSURES AND DEVICES WITH INTEGRATED BATTERY

Application:



09/816602

Confirmation: 6174

Applicant(s): Mark Jensen

Docket

1327.010US1

Number:

Group Art

1745

Unit:

Examiner: Unknown,Unknown

search string:

(US-4,299,890 or US-4,333,808 or US-4,365,107 or US-4,730,383 or US-4,740,431 or US-5,051,274 or US-5,151,848 or US-5,171,413 or US-5,180,645 or US-5,189,550 or US-5,192,947 or US-5,338,625 or US-5,411,592 or US-5,425,966 or US-5,426,561 or US-5,445,906 or US-5,448,110 or US-5,468,521 or US-5,549,989 or US-5,558,953 or US-5,571,749 or US-5,626,976 or US-5,644,207 or US-5,695,885 or US-5,763,058 or US-5,872,080 or US-5,978,207 or US-6,094,292 or US-6,222,117 or US-6,236,061).pn.

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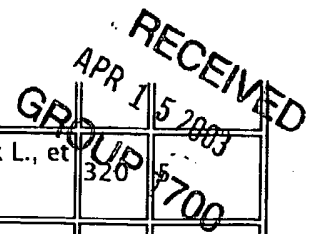
Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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Signature

Examiner Name	Date
	7/6/03

Form 1449*	Atty. Docket No.: 1327.010US1	Serial No. Unknown
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Applicant: Mark Lynn Jenson et al.	
	Filing Date: Herewith	Group: Unknown

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09/816602
03/23/01

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Examiner <i>J. Lynn</i>	Date Considered 12/10/04
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